

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/081,819	CLAPPER, EDWARD O.	
Examiner		Art Unit		Page 1 of 1
Olisa Anwah		2614		

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,658,268	12-2003	Bodnar et al.	455/556.2
*	B	US-2002/0174110	11-2002	Smith, Gordon James	707/3
*	C	US-2003/0147518	08-2003	ALBAL et al.	379/207.15
*	D	US-6,270,271	08-2001	Fujiwara, Hitoshi	400/693
*	E	US-6,459,782	10-2002	Bedrosian et al.	379/201.08
*	F	US-2002/0159574	10-2002	Stogel, Scott	379/93.01
*	G	US-2001/0027098	10-2001	Suzuki, Naoya	455/415
*	H	US-6,266,539	07-2001	Pardo, Teddy	455/556.2
*	I	US-6,873,692	03-2005	Silver et al.	379/142.17
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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